

Search Notes

Application/Control No.

10/611,419

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

FU ET AL.

Art Unit

2652

SEARCHED

Class	Subclass	Date	Examiner
360	264.7		
	264.8		
	264.9		
	265		
310	12		
	15	10/19/2005	TJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner